

Notice of References Cited

Application/Control No.

10/725,989

Applicant(s)/Patent Under
Reexamination
ABE ET AL.

Examiner

Manglesh M. Patel

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0143739	10-2002	Makino et al.	707/1
*	B	US-5,974,370	10-1999	Suda et al.	704/2
*	C	US-6,735,559	05-2004	Takazawa, Kazuhisa	704/7
*	D	US-6,785,869	08-2004	Berstis, Viktors	715/532
*	E	US-7,137,076	11-2006	Iwema et al.	715/863
*	F	US-6,128,635	10-2000	Ikeno, Atsushi	715/532
*	G	US-7,124,364	10-2006	Rust et al.	715/532
*	H	US-6,961,722	11-2005	Bruecken, Carl	707/3
*	I	US-2004/0210435	10-2004	Oshima, Jun	704/010
*	J	US-5,745,776	04-1998	Sheppard, II, Charles Bradford	715/532
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2336694 A	10-1999	United Kingdom	RANDALL, ANTHONY	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Franklin, Merriam-Webster's Collegiate Dictionary (11th Edition) SCD-1870 Users Guide, 2003, Franklin, pgs 1-76
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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